

January 2011 SupreMOS®

FCH25N60N

N-Channel MOSFET 600V, 25A, 0.126 Ω

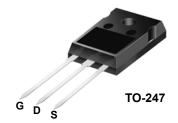
Features

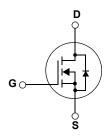
- $R_{DS(on)}$ = 0.108 Ω (Typ.) at V_{GS} = 10V, I_D = 12.5A
- Ultra Low Gate Charge (Typ. Qg = 57nC)
- · Low Effective Output Capacitance
- · 100% Avalanche Tested
- · RoHS Compliant

Description

The SupreMOS MOSFET, Fairchild's next generation of high voltage super-junction MOSFETs, employs a deep trench filling process that differentiates it from preceding multi-epi based technologies. By utilizing this advanced technology and precise process control, SupreMOS provides world class Rsp, superior switching performance and ruggedness.

This SupreMOS MOSF ET fits the industry's AC-DC SMPS requirements for PFC, server/telecom power, FPD TV power, ATX power, and industrial power applications.





MOSFET Maximum Ratings T_C = 25°C unless otherwise noted*

Symbol		Parameter		FCH25N60N	Units	
V _{DSS}	Drain to Source Voltage			600	V	
V _{GSS}	Gate to Source Voltage	Gate to Source Voltage		±30	V	
ı	Continuous ($T_C = 25^{\circ}C$)			25	۸	
I _D	Drain Current	Continuous (T _C = 100°C)		16	A	
I _{DM}	Drain Current	Pulsed	(Note 1)	75	Α	
E _{AS}	Single Pulsed Avalanche Energy (Note 2)		861	mJ		
I _{AR}	Avalanche Current		8.3	Α		
E _{AR}	Repetitive Avalanche Energy		2.2	mJ		
dv/dt	Peak Diode Recovery dv/dt (Note 3)		(Note 3)	20	V/ns	
uv/ul	MOSFET dv/dt			100	V/IIS	
D	Dower Dissipation	(T _C = 25°C)		216	W	
P _D Power Dissipation		Derate above 25°C		1.72	W/°C	
T _J , T _{STG}	Operating and Storage Te	mperature Range		-55 to +150	οС	
T _L	Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds		300	°C		

^{*}Drain current limited by maximum junction temperature

Thermal Characteristics

Symbol	Parameter	FCH25N60N	Units
$R_{\theta JC}$	Thermal Resistance, Junction to Case	0.58	
$R_{\theta CS}$	Thermal Resistance, Case to Heat Sink (Typical)	0.24	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	40	

Units

Max.

Package Marking and Ordering Information $T_C = 25^{\circ}C$ unless otherwise noted

Parameter

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FCH25N60N	FCH25N60N	TO247	-	-	30

Test Conditions

Min.

Тур.

Electrical Characteristics

Off Chara	acteristics					
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 1 \text{mA}, V_{GS} = 0 \text{V}, T_J = 25^{\circ} \text{C}$	600	-	-	V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I _D = 1mA, Referenced to 25°C	-	0.74	-	V/°C
ı	Zero Gate Voltage Drain Current	V _{DS} = 480V, V _{GS} = 0V	-	-	10	μА
DSS	Zero Gate voltage Dialii Guilent	$V_{DS} = 480V, T_J = 125^{\circ}C$	-	-	100	μΑ
I _{GSS}	Gate to Body Leakage Current	$V_{GS} = \pm 30V, V_{DS} = 0V$	-	-	±100	nA

On Characteristics

Symbol

V _{GS(th)}	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$	2.0	-	4.0	V
R _{DS(on)}	Static Drain to Source On Resistance	$V_{GS} = 10V, I_D = 12.5A$	1	0.108	0.126	Ω
g _{FS}	Forward Transconductance	V _{DS} = 20V, I _D = 12.5A	-		-	S

Dynamic Characteristics

C _{iss}	Input Capacitance	\(- 400\\ \) \(- 0\\ \)	-	2520	3352	pF
C _{oss}	Output Capacitance	$V_{DS} = 100V, V_{GS} = 0V$ 	-	103	137	pF
C _{rss}	Reverse Transfer Capacitance	1 - 11/11/2	-	3.2	5	pF
C _{oss}	Output Capacitance	$V_{DS} = 380V, V_{GS} = 0V, f = 1MHz$	-	55	-	pF
C _{oss} eff.	Effective Output Capacitance	V_{DS} = 0V to 480V, V_{GS} = 0V	-	262	-	pF
Q _{g(tot)}	Total Gate Charge at 10V		-	57	74	nC
Q_{gs}	Gate to Source Gate Charge	$V_{DS} = 380V, I_{D} = 12.5A,$	-	10	-	nC
Q _{gd}	Gate to Drain "Miller" Charge	V _{GS} = 10V (Note 4)	-	18	-	nC
ESR	Equivalent Series Resistance (G-S)	Drain Open, f=1MHz	-	1	-	Ω

Switching Characteristics

t _{d(on)}	Turn-On Delay Time			-	21	52	ns
t _r	Turn-On Rise Time		V _{DD} = 380V, I _D = 12.5A		22	54	ns
t _{d(off)}	Turn-Off Delay Time	$R_G = 4.7\Omega$		-	68	146	ns
t _f	Turn-Off Fall Time		(Note 4)	-	5	20	ns

Drain-Source Diode Characteristics

I_S	Maximum Continuous Drain to Source Diode Forward Current		-	-	25	Α
I _{SM}	Maximum Pulsed Drain to Source Diode Forward Current		-	-	75	Α
V_{SD}	Drain to Source Diode Forward Voltage	V _{GS} = 0V, I _{SD} = 12.5A	-	-	1.2	V
t _{rr}	Reverse Recovery Time	V _{GS} = 0V, I _{SD} = 12.5A	-	370	-	ns
Q _{rr}	Reverse Recovery Charge	$dI_F/dt = 100A/\mu s$	-	7	-	μС

Notes:

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature
- 2. I_{AS} = 8.3A, R_G = 25 Ω , Starting T_J = 25 $^{\circ}C$
- 3. I_{SD} \leq 25A, di/dt \leq 200A/µs, V_{DD} \leq 380V, Starting T_J = 25°C
- 4. Essentially Independent of Operating Temperature Typical Characteristics

Typical Performance Characteristics

Figure 1. On-Region Characteristics

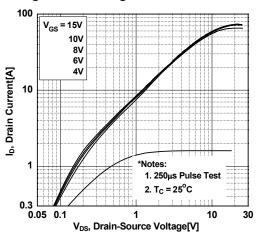


Figure 3. On-Resistance Variation vs.

Drain Current and Gate Voltage

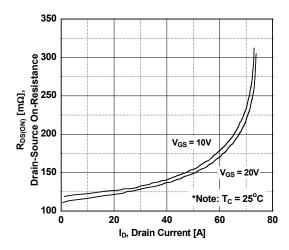


Figure 5. Capacitance Characteristics

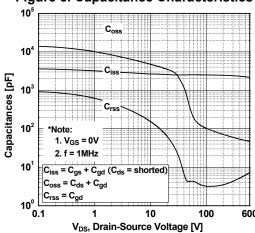


Figure 2. Transfer Characteristics

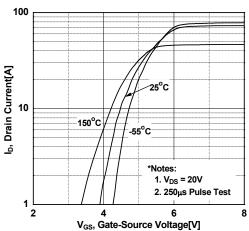


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

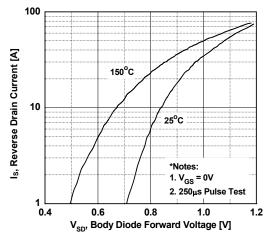
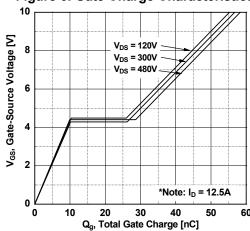


Figure 6. Gate Charge Characteristics



Typical Performance Characteristics (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

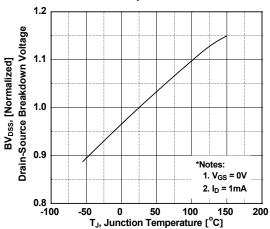


Figure 8. On-Resistance Variation vs. Temperature

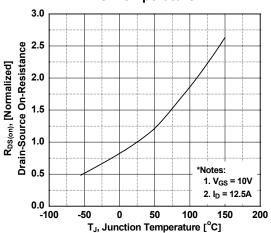


Figure 9. Maximum Safe Operating Area

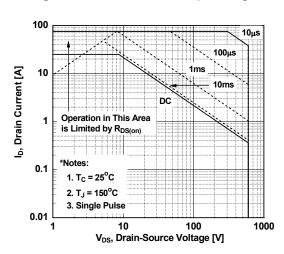


Figure 10. Maximum Drain Current vs. Case Temperature

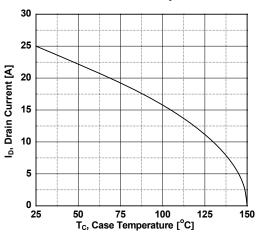
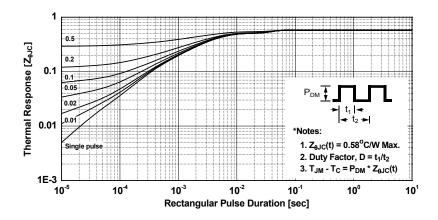
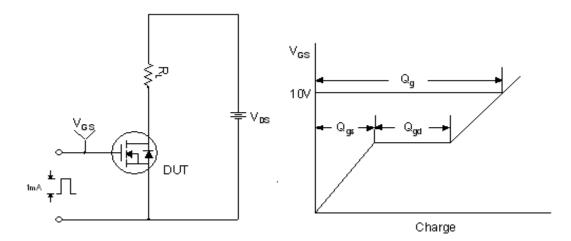


Figure 11. Transient Thermal Response Curve

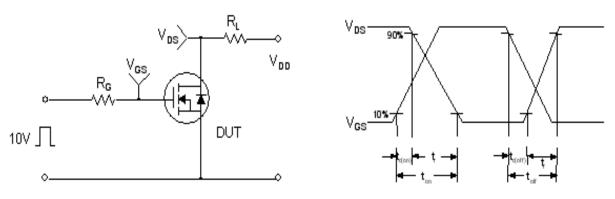


V_{os}(t) Time

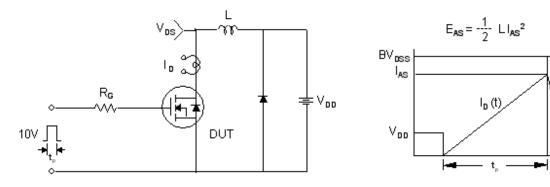
Gate Charge Test Circuit & Waveform



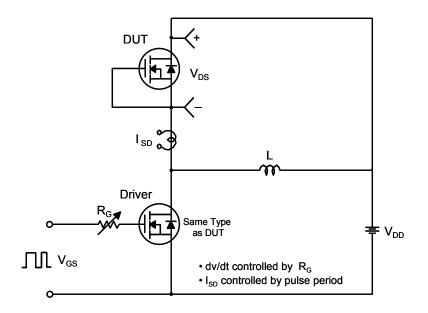
Resistive Switching Test Circuit & Waveforms

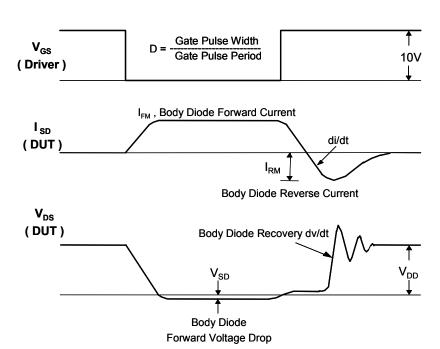


Unclamped Inductive Switching Test Circuit & Waveforms



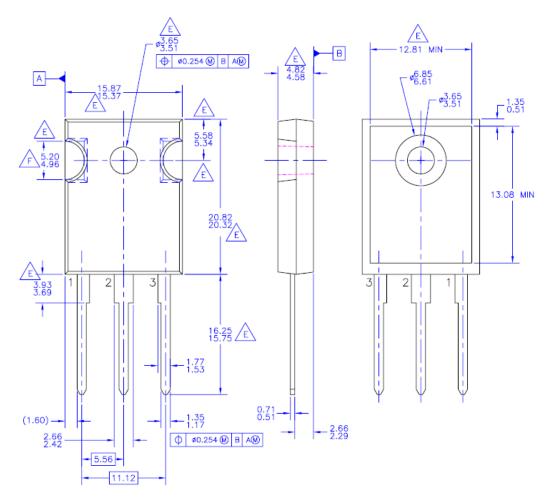
Peak Diode Recovery dv/dt Test Circuit & Waveforms





Mechanical Dimensions

TO-247-3L



NOTES; UNLESS OTHERWISE SPECIFIED

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